



18. TEST PHOTOGRAPHS

See following Attached Pages for setup photographs.

| | | | | |
|--|---|---------------------------------------|---|--|
| FCC ID: A3LSMG986W |  PCTEST ENGINEERING LABORATORY, INC. | HAC (RF EMISSIONS) TEST REPORT |  | Approved by: Quality Manager |
| Filename: 1M1911010179-14-R1.A3L | Test Dates: 12/02/2019 - 12/13/2019 | DUT Type: Portable Handset | Page 83 of 85 | |

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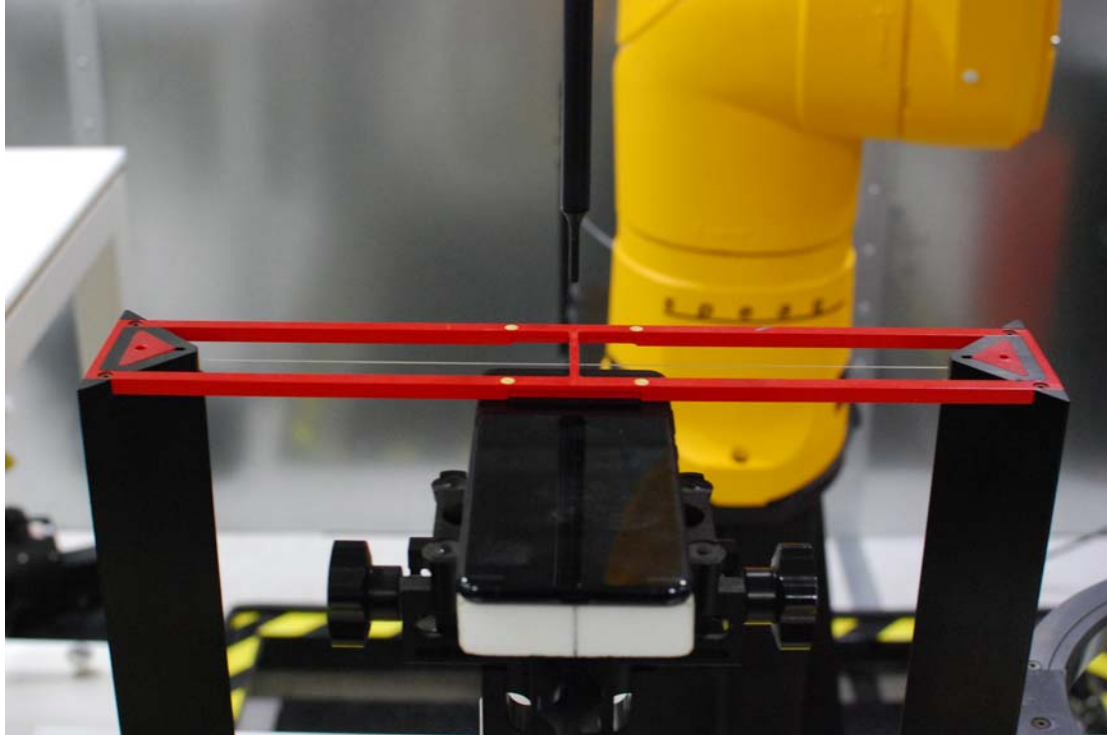


Figure 18-1
Ear Reference Point HAC Phantom Alignment

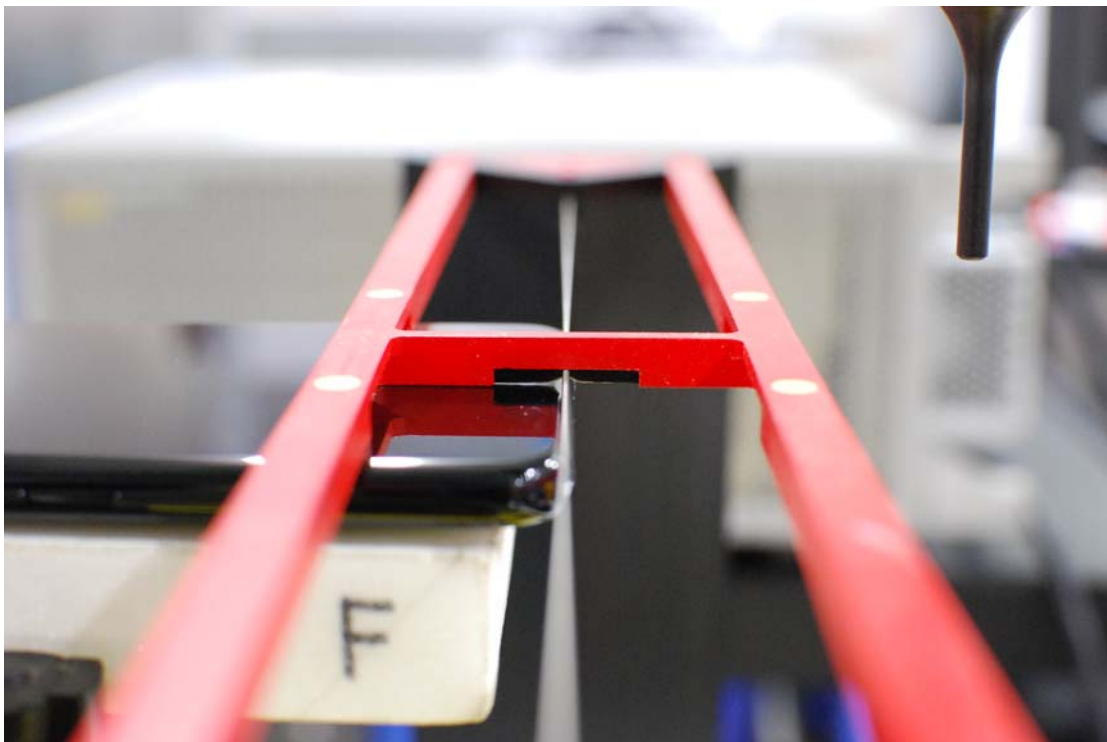




Figure 18-2
HAC Phantom Plane Alignment

| | | | | |
|-------------------------------------|--|--------------------------------|---|---------------------------------|
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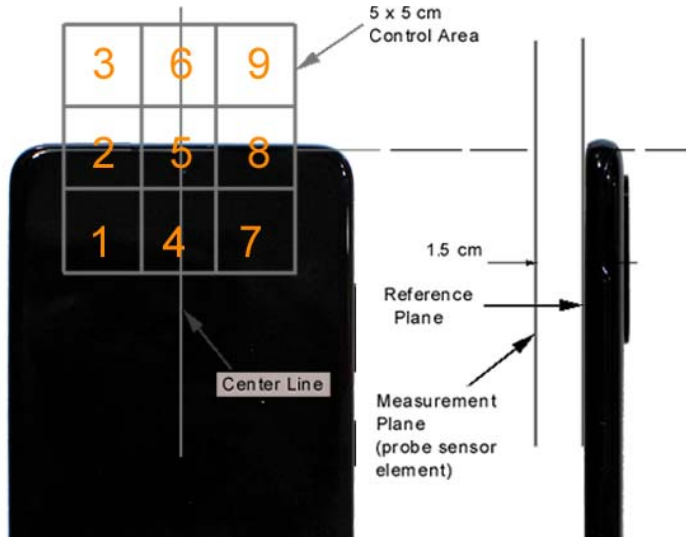




Figure 18-3 5x5 Scan grid above WD



Figure 18-4 E-Field WD Scan overlay

| | | | | |
|-------------------------------------|--|--------------------------------|---|---------------------------------|
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